WHAT IS CLAIMED IS:

1	1.		A method for isolating failed routing resources on a programmable		
2	integrated circuit, the method comprising:				
3	receiving a set of failed test patterns that generated erroneous results when				
4	applied to a set of failed test paths, the failed test paths connecting together routing resources				
5	on the programmable integrated circuit;				
6	id	lentify	ring a subset of the routing resources that occur most frequently in the		
7	failed test paths; and				
8	generating new test patterns including new test paths for the subset of the				
9	routing resources that occurred most frequently in the failed test paths.				
1	2.		The method according to claim 1 further comprising:		
2	testing the new test patterns using a test system to isolate routing resources				
3	among the subset of the routing resources that caused the erroneous results in the failed test				
4	patterns.				
1	3.		The method according to claim 1 wherein generating the new test		
2			of the routing resources further comprises:		
3	-		ing new test patterns for new test paths that route through every		
4	combination of fan-in resources and fan-out resources that are programmably connectable to				
5			ne routing resources.		
1	4.		The method according to claim 1 wherein generating the new test		
2	patterns for the subset of the routing resources further comprises:				
3	_	•	ing new test patterns for test paths that route through clock and clear		
4	signal routing res	source	S.		
1	5.		The method according to claim 1 wherein each of the failed test paths		
2	and the new test paths connect a control point to an observation point on the programmable				
3	integrated circuit	t.			
1	6.		The method according to claim 1 wherein the routing resources have		
2			as many routing resources as the subset of routing resources.		
-	more man 1000 t.		and many routing resources as the subset of routing resources.		
1	7.		The method according to claim 5 further comprising:		

2	receiving a test log file that indicates the observation points for the failed test				
3	paths.				
1	8. The method according to claim 1 wherein identifying the subset of the				
2	routing resources that occur most frequently in the failed test paths further comprises:				
3	extracting the routing resources that are connected along each of the failed test				
4	paths using a connectivity graph.				
1	9. A computer program product encoded on a computer readable medium				
2	for isolating failed routing resources on a programmable integrated circuit, the computer				
3	readable medium comprising:				
4	code for receiving a set of failed test patterns generating erroneous results				
5	when applied to a set of failed test paths that connect together routing resources on the				
6	programmable integrated circuit and identifying a subset of the routing resources that occur				
7	most frequently in the failed test paths; and				
8	code for generating new test patterns including new test paths for the subset of				
9	the routing resources that occurred most frequently in the failed test paths.				
1	10. The computer program product of claim 9 wherein the code for				
2	receiving and identifying further comprises:				
3	code for receiving a test log file that indicates observation points for the failed				
4	test paths.				
1	11. The computer program product of claim 9 wherein the code for				
2	generating further comprises:				
3	code for generating new test patterns for test paths that route through clock				
4	and clear signal routing resources.				
1	12. The computer program product of claim 9 further comprising:				
2	code for testing the new test patterns to isolate routing resources among the				
3	subset that caused the erroneous results in the failed test patterns.				
1	13. The computer program product of claim 9 wherein the code for				
2	generating further comprises:				

3	code for generating new test patterns that route through every combination of				
4	fan-in resources and fan-out resources that are programmably connectable to each of the				
5	subset of the routing resources.				
1	14. The computer program product of claim 9 wherein the routing				
2	resources have more than 10,000 times as many routing resources as the subset of the routing				
3	resources.				
1	15. A computer system for isolating failed routing resources on a				
2	programmable integrated circuit, the computer system comprising:				
3	a statistical failure isolation (SFI) tool that identifies a subset of routing				
4	resources that occur most frequently in failed test paths, wherein the SFI tool receives a set of				
5	failed test patterns that generated erroneous results when applied to the failed test paths, the				
6	failed test paths connecting together the routing resources on the programmable integrated				
7	circuit; and				
8	an adaptive failure isolation (AFI) tool that generates new test patterns				
9	including new test paths for the subset of the routing resources that occurred most frequently				
10	in the failed test paths.				
1	16. The computer system according to claim 15 wherein the SFI tool also				
2	receives a test log file that indicates observation points for the failed test paths.				
1	17. The computer system according to claim 15 further comprising:				
2	a test system that tests the new test patterns to isolate routing resources among				
3	the subset that caused the erroneous results in the failed test patterns.				
1	18. The computer system according to claim 15 wherein:				
2	the AFI tool generates new test patterns for new test paths that route through				
3	every combination of fan-in resources and fan-out resources that are programmably				
4	connectable to each of the subset of the routing resources.				
1	19. The computer system according to claim 15 wherein the routing				
2	resources have more than 1000 times as many routing resources as the subset of routing				
3	resources.				

- 1 20. The computer system according to claim 15 wherein the SFI tool
- 2 extracts the routing resources that are connected along each of the failed test paths using a
- 3 connectivity graph.